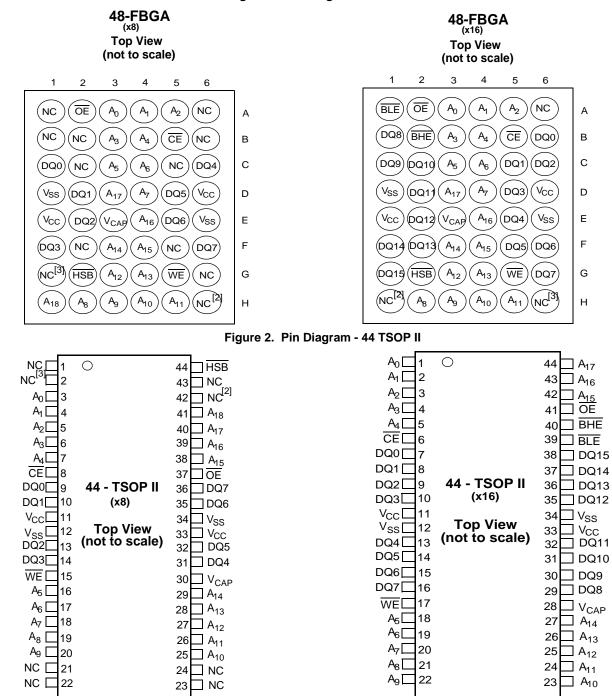


Pinouts

Figure 1. Pin Diagram - 48 FBGA



Notes

2. Address expansion for 8 Mbit. NC pin not connected to die.

3. Address expansion for 16 Mbit. NC pin not connected to die.



Pinouts (continued)

Figure 3. Pin Diagram - 54 Pin TSOP II (x16)

$\begin{array}{c c c c c c c c c c c c c c c c c c c $	54 HSB 53 NC ^[2] 52 A ₁₇ 51 A ₁₆ 50 A ₁₅ 49 OE 48 BHE 47 BLE 46 DQ15 45 DQ14 44 DQ13 43 DQ12 42 V _{SS} 41 V _{CC} 40 DQ10 38 DQ9 37 DQ8 36 V _{CAP} 35 A ₁₄ 34 A ₁₃ 33 A ₁₂ 32 A ₁₁ 31 A ₁₀ 30 NC 28 NC
--	---

Pin Definitions

Pin Name	Ю Туре	Description
$A_0 - A_{18}$	Input	Address Inputs Used to Select one of the 524, 288 bytes of the nvSRAM for x8 Configuration.
$A_0 - A_{17}$		Address Inputs Used to Select one of the 262,144 bytes of the nvSRAM for x16 Configuration.
DQ0 – DQ7	Input/Output	Bidirectional Data IO Lines for x8 Configuration. Used as input or output lines depending on operation.
DQ0 – DQ15		Bidirectional Data IO Lines for x16 Configuration. Used as input or output lines depending on operation.
WE	Input	Write Enable Input, Active LOW. When selected LOW, data on the IO pins is written to the address location latched by the falling edge of CE.
CE	Input	Chip Enable Input, Active LOW. When LOW, selects the chip. When HIGH, deselects the chip.
OE	Input	Output Enable, Active LOW. The active LOW OE input enables the data output buffers during read cycles. IO pins are tri-stated on deasserting OE HIGH.
BHE	Input	Byte High Enable, Active LOW. Controls DQ15 - DQ8.
BLE	Input	Byte Low Enable, Active LOW. Controls DQ7 - DQ0.
V _{SS}	Ground	Ground for the Device. Must be connected to the ground of the system.
V _{CC}	Power Supply	Power Supply Inputs to the Device.
HSB	Input/Output	Hardware Store Busy (HSB) . When LOW this output indicates that a hardware store is in progress. When pulled LOW external to the chip it initiates a nonvolatile STORE operation. A weak internal pull up resistor keeps this pin HIGH if not connected (connection optional).
V _{CAP}	Power Supply	AutoStore Capacitor. Supplies power to the nvSRAM during power loss to store data from SRAM to nonvolatile elements.
NC	No Connect	No Connect. Do not connect this pin to the die.

PRELIMINARY



Device Operation

The CY14B104L/CY14B104N nvSRAM is made up of two functional components paired in the same physical cell. They are an SRAM memory cell and a nonvolatile QuantumTrap cell. The SRAM memory cell operates as a standard fast static RAM. Data in the SRAM is transferred to the nonvolatile cell (the STORE operation), or from the nonvolatile cell to the SRAM (the RECALL operation). Using this unique architecture, all cells are stored and recalled in parallel. During the STORE and RECALL operations, SRAM read and write operations are inhibited. The CY14B104L/CY14B104N supports infinite reads and writes similar to a typical SRAM. In addition, it provides infinite RECALL operations.

SRAM Read

The <u>CY</u>14B104L/CY14B104N performs a read cycle when \overline{CE} and \overline{OE} are LOW and \overline{WE} and HSB are HIGH. The address specified on pins A₀₋₁₈ or A₀₋₁₇ determines which of the 524,288 data bytes or 262,144 words of 16 bits each are accessed. When the read is initiated by an address transition, the outputs are valid after a delay of t_{AA} (read cycle #1). If the read is initiated by \overline{CE} or \overline{OE} , the outputs are valid at t_{ACE} or at t_{DOE}, whichever is later (read cycle #2). The data output repeatedly responds to address changes within the t_{AA} access time without the need for transitions on any control input pins. This remains valid until another address change or until \overline{CE} or \overline{OE} is brought HIGH, or \overline{WE} or HSB is brought LOW.

SRAM Write

A write cycle is performed when \overline{CE} and \overline{WE} are LOW and \overline{HSB} is HIGH. The address inputs must be stable before entering the write cycle and must remain stable until \overline{CE} or \overline{WE} goes HIGH at the end of the cycle. The data on the common IO pins DQ_{0-15} are written into the memory if the data is valid t_{SD} before the end of a WE controlled write or before the end of an \overline{CE} controlled write. It is recommended that \overline{OE} be kept HIGH during the entire write cycle to avoid data bus contention on common IO lines. If \overline{OE} is left LOW, internal circuitry turns off the output buffers t_{HZWE} after \overline{WE} goes LOW.

AutoStore Operation

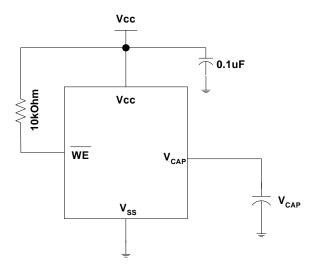
The CY14B104L/CY14B104N stores data to the nvSRAM using one of the following three storage operations: Hardware Store activated by HSB; Software Store activated by an address sequence; AutoStore on device power down. The AutoStore operation is a unique feature of QuantumTrap technology and is enabled by default on the CY14B104L/CY14B104N.

During a normal operation, the device draws current from V_{CC} to charge a capacitor connected to the V_{CAP} pin. This stored charge is used by the chip to perform a single STORE operation. If the voltage on the V_{CC} pin drops below V_{SWITCH}, the part automatically disconnects the V_{CAP} pin from V_{CC}. A STORE operation is initiated with power provided by the V_{CAP} capacitor.

Figure 4 shows the proper connection of the storage capacitor (V_{CAP}) for automatic store operation. Refer to DC Electrical Characteristics on page 7 for the size of V_{CAP}.

To reduce unnecessary nonvolatile stores, AutoStore and hardware store operations are ignored unless at least one write operation has taken place since the most recent STORE or RECALL cycle. Software initiated STORE cycles are performed regardless of whether a write operation has taken place. The HSB signal is monitored by the system to detect if an AutoStore cycle is in progress.

Figure 4. AutoStore Mode



Hardware STORE Operation

The CY14B104L/CY14B104N provides the HSB pin to control and acknowledge the STORE operations. Use the HSB pin to request a hardware STORE cycle. When the HSB pin is driven LOW, the CY14B104L/CY14B104N conditionally initiates a STORE operation after t_{DELAY} . An actual STORE cycle only begins if a write to the SRAM has taken place since the last STORE or RECALL cycle. The HSB pin also acts as an open drain driver that is internally driven LOW to indicate a busy condition when the STORE (initiated by any means) is in progress.

SRAM read and write operations that are in progress when HSB is driven LOW by any means are given time to complete before the STORE operation is initiated. After HSB goes LOW, the CY14B104L/CY14B104N continues SRAM operations for t_{DELAY}. During t_{DELAY}, multiple SRAM read operations may take place. If a write is in progress when HSB is pulled low it is allowed a time, t_{DELAY} to complete. However, any SRAM write cycles requested after HSB goes LOW are inhibited until HSB returns HIGH.

During any STORE operation, regardless of how it is <u>initiated</u>, the CY14B104L/CY14B104N continues to drive the HSB pin LOW,releasing it only when the STORE is complete.Upon completion of the STORE operation, the CY14B104L/CY14B104N remains disabled until the HSB pin returns HIGH. Leave the HSB unconnected if it is not used.





Hardware RECALL (Power Up)

During power up or after any low power condition (V_{CC} < V_{SWITCH}), an internal RECALL request is latched. When V_{CC} again exceeds the sense voltage of V_{SWITCH} , a RECALL cycle is automatically initiated and takes $t_{HRECALL}$ to complete.

Software STORE

Transfer data from the SRAM to the nonvolatile memory with a software address sequence. The CY14B104L/CY14B104N software STORE cycle is initiated by executing sequential CE controlled read cycles from six specific address locations in exact order. During the STORE cycle an erase of the previous nonvolatile data is first performed, followed by a program of the nonvolatile elements. After a STORE cycle is initiated, further input and output are disabled until the cycle is completed.

Because a sequence of READs from specific addresses is used for STORE initiation, it is important that no other read or write accesses intervene in the sequence, or the sequence is aborted and no STORE or RECALL takes place.

To initiate the software STORE cycle, the following read sequence must be performed.

- 1. Read Address 0x4E38 Valid READ
- 2. Read Address 0xB1C7 Valid READ
- 3. Read Address 0x83E0 Valid READ
- 4. Read Address 0x7C1F Valid READ
- 5. Read Address 0x703F Valid READ
- 6. Read Address 0x8FC0 Initiate STORE Cycle

Table 1. Mode Selection

The software sequence may be clocked with $\overline{\text{CE}}$ controlled reads or $\overline{\text{OE}}$ controlled reads. After the sixth address in the sequence is entered, the STORE cycle commences and the chip is disabled. It is important to use read cycles and not write cycles in the sequence, although it is not necessary that $\overline{\text{OE}}$ be LOW for a valid sequence. After the t_{STORE} cycle time is fulfilled, the SRAM is activated again for the read and write operation.

Software RECALL

Transfer the data from the nonvolatile memory to the SRAM with a software address sequence. A software RECALL cycle is initiated with a sequence of read operations in a manner similar to the software STORE initiation. To initiate the RECALL cycle, the following sequence of CE controlled read operations must be performed.

- 1. Read Address 0x4E38 Valid READ
- 2. Read Address 0xB1C7 Valid READ
- 3. Read Address 0x83E0 Valid READ
- 4. Read Address 0x7C1F Valid READ
- 5. Read Address 0x703F Valid READ
- 6. Read Address 0x4C63 Initiate RECALL Cycle

Internally, RECALL is a two step procedure. First, the SRAM data is cleared; then, the nonvolatile information is transferred into the SRAM cells. After the t_{RECALL} cycle time, the SRAM is again ready for read and write operations. The RECALL operation does not alter the data in the nonvolatile elements.

CE	WE	OE	A15 - A0	Mode	ю	Power
Н	Х	Х	Х	Not Selected	Output High Z	Standby
L	Н	L	Х	Read SRAM	Output Data	Active
L	L	Х	Х	Write SRAM	Input Data	Active
L	H	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8B45	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Disable	Output Data Output Data Output Data Output Data Output Data Output Data	Active ^[4,5,6]
L	H	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4B46	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Enable	Output Data Output Data Output Data Output Data Output Data Output Data	Active ^[4,5,6]

Notes

- 5. While there are 19 address lines on the CY14B104L/CY14B104N, only the lower 16 lines are used to control software modes.
- 6. IO state depends on the state of OE, BHE, and BLE. The IO table shown assumes OE, BHE, and BLE LOW.

^{4.} The six consecutive address locations must be in the order listed. WE must be HIGH during all six cycles to enable a nonvolatile cycle.



Table 1. Mode Selection (continued)

CE	WE	OE	A15 - A0	Mode	ю	Power
L	H	Ĺ	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8FC0	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile Store	Output Data Output Data Output Data Output Data Output Data Output High Z	Active I _{CC2} ^[4,5,6]
L	Н	L	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4C63	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile Recall	Output Data Output Data Output Data Output Data Output Data Output High Z	Active ^[4,5,6]

Preventing AutoStore

The AutoStore function is disabled by initiating an AutoStore disable sequence. A sequence of read operations is performed in a manner similar to the software STORE initiation. To initiate the AutoStore disable sequence, the following sequence of CE controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x8B45 AutoStore Disable

The AutoStore is re-enabled by initiating an AutoStore enable sequence. A sequence of read operations is performed in a manner similar to the software RECALL initiation. To initiate the AutoStore enable sequence, the following sequence of CE controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x4B46 AutoStore Enable

If the AutoStore function is disabled or re-enabled, a manual STORE operation (hardware or software) must be issued to save the AutoStore state through subsequent power down cycles. The part comes from the factory with AutoStore enabled.

Data Protection

The CY14B104L/CY14B104N protects data from corruption during low voltage conditions by inhibiting all externally initiated STORE and write operations. The low voltage condition is detected when $V_{CC} < V_{SWITCH}$. If the CY14B104L/CY14B104N is in a write mode (both CE and WE are LOW) at power up, after a RECALL or STORE, the write is inhibited until a negative transition on CE or WE is detected. This protects against inadvertent writes during power up or brown out conditions.

Noise Considerations

Refer CY application note AN1064.



CY14B104L, CY14B104N

Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

Storage Temperature65°C to +150°C
Ambient Temperature with Power Applied55°C to +150°C
Supply Voltage on V_{CC} Relative to GND–0.5V to 4.1V
Voltage Applied to Outputs in High-Z State–0.5V to V_{CC} + 0.5V
Input Voltage0.5V to Vcc+0.5V
Transient Voltage (<20 ns) on Any Pin to Ground Potential–2.0V to V_{CC} + 2.0V

DC Electrical Characteristics

Over the Operating Range $(V_{CC} = 2.7V \text{ to } 3.6V)^{[9]}$

Package Power Dissipation Capability $(T_A = 25^{\circ}C)$	1.0W
Surface Mount Pb Soldering Temperature (3 Seconds)	+260°C
Output Short Circuit Current [7]	15 mA
Static Discharge Voltage (per MIL-STD-883, Method 3015)	> 2001V
Latch Up Current	> 200 mA

Operating Range

Range	Ambient Temperature	V _{CC}			
Commercial	0°C to +70°C	2.7V to 3.6V			
Industrial	–40°C to +85°C	2.7V to 3.6V			

Parameter	Description	Test Conditions		Min	Max	Unit mA mA mA
I _{CC1}	Average V _{CC} Current	$t_{RC} = 15 \text{ ns}$ $t_{RC} = 20 \text{ ns}$ $t_{RC} = 25 \text{ ns}$ $t_{RC} = 45 \text{ ns}$	Commercial		70 65 65 50	
		Dependent on output loading and cycle rate.Values obtained without output loads. I _{OUT} = 0 mA	Industrial		75 70 70 52	mA mA mA
I _{CC2}	Average V _{CC} Current during STORE	All Inputs Don't Care, V _{CC} = Max Average current for duration t _{STORE}			6	mA
I _{CC3} ^[8]	Average V _{CC} Current at t _{RC} = 200 ns, 3V, 25°C typical	WE > (V _{CC} – 0.2). All other I/P cycling. Dependent on output loading and cycle rate. Va without output loads.		35	mA	
I _{CC4}	Average V _{CAP} Current during AutoStore Cycle	All Inputs Don't Care, V _{CC} = Max Average current for duration t _{STORE}		6	mA	
I _{SB}	V _{CC} Standby Current	CE > (V_{CC} – 0.2). All others V_{IN} < 0.2V or > (V_{C} Standby current level after nonvolatile cycle is o Inputs are static. f = 0 MHz.		3	mA	
I _{IX}	Input Le <u>aka</u> ge Current (except HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$		-1	+1	μA
	Inpu <u>t Lea</u> kage Current (for HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$		-100	+1	μA
I _{OZ}	Off-State Output Leakage Current	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}, \overline{CE} \text{ or } \overline{OE} > V_{IH}$		-1	+1	μA
V _{IH}	Input HIGH Voltage			2.0	V _{CC} + 0.5	V
V _{IL}	Input LOW Voltage			$V_{ss} - 0.5$	0.8	V
V _{OH}	Output HIGH Voltage	I _{OUT} = -2 mA		2.4		V
V _{OL}	Output LOW Voltage	I _{OUT} = 4 mA			0.4	V
V _{CAP}	Storage Capacitor	Between V_{CAP} pin and V_{SS} , 5V Rated		61	82	μF

Notes

Outputs shorted for no more than one second. Only one output shorted at a time.
 Typical conditions for the active current shown on the front page of the data sheet are average values at 25°C (room temperature), and V_{CC} = 3V. Not 100% tested.

9. The HSB pin has I_{OUT}=-10 uA for V_{OH} of 2.4V.This parameter is characterized but not tested.



Capacitance

In the following table, the capacitance parameters are listed.^[10]

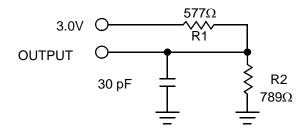
Parameter	Description	Test Conditions	Max	Unit
C _{IN}	Input Capacitance	$T_{A} = 25^{\circ}C, f = 1 \text{ MHz},$	7	pF
C _{OUT}	Output Capacitance	$V_{CC} = 0$ to 3.0V	7	pF

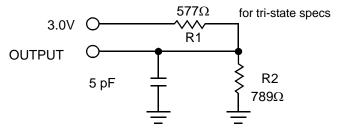
Thermal Resistance

In the following table, the thermal resistance parameters are listed. ^[10]

Parameter	Description	Test Conditions	48-FBGA	44-TSOP II	54-TSOP II	Unit
Θ_{JA}	· /	Test conditions follow standard test methods and procedures for measuring thermal	28.82	31.11	30.73	°C/W
Θ_{JC}	Thermal Resistance (Junction to Case)	impedance, in accordance with EIA/JESD51.	7.84	5.56	6.08	°C/W

Figure 5. AC Test Loads





AC Test Conditions

Input Pulse Levels	0V to 3V
Input Rise and Fall Times (10% - 90%)	<5 ns
Input and Output Timing Reference Levels	1.5V

10. These parameters are guaranteed but not tested.



AC Switching Characteristics

Paran	neters		15	ns	20	ns	25	ns	45 ns		
Cypress Parameters	Alt Parameters	Description	Min	Max	Min	Max	Min	Max	Min	Max	Unit
SRAM Read	Cycle	•		•			•	•	•	•	
t _{ACE}	t _{ACS}	Chip Enable Access Time		15		20		25		45	ns
t _{RC} ^[11]	t _{RC}	Read Cycle Time	15		20		25		45		ns
t _{AA} ^[12]	t _{AA}	Address Access Time		15		20		25		45	ns
t _{DOE}	t _{OE}	Output Enable to Data Valid		10		10		12		20	ns
t _{OHA}	t _{OH}	Output Hold After Address Change	3		3		3		3		ns
t _{LZCE} ^[13]	t _{LZ}	Chip Enable to Output Active	3		3		3		3		ns
t _{HZCE} ^[13]	t _{HZ}	Chip Disable to Output Inactive		7		8		10		15	ns
t _{LZOE} ^[13]	t _{OLZ}	Output Enable to Output Active	0		0		0		0		ns
t _{HZOE} ^[13]	t _{OHZ}	Output Disable to Output Inactive		7		8		10		15	ns
t _{PU} ^[10]	t _{PA}	Chip Enable to Power Active	0		0		0		0		ns
t _{PD} ^[10]	t _{PS}	Chip Disable to Power Standby		15		20		25		45	ns
t _{DBE}	-	Byte Enable to Data Valid		10		10		12		20	ns
t _{LZBE}	-	Byte Enable to Output Active	0		0		0		0		ns
t _{HZBE}	-	Byte Disable to Output Inactive		7		8		10		15	ns
SRAM Write	Cycle										
t _{WC}	t _{WC}	Write Cycle Time	15		20		25		45		ns
t _{PWE}	t _{WP}	Write Pulse Width	10		15		20		30		ns
t _{SCE}	t _{CW}	Chip Enable To End of Write	15		15		20		30		ns
t _{SD}	t _{DW}	Data Setup to End of Write	5		8		10		15		ns
t _{HD}	t _{DH}	Data Hold After End of Write	0		0		0		0		ns
t _{AW}	t _{AW}	Address Setup to End of Write	10		15		20		30		ns
t _{SA}	t _{AS}	Address Setup to Start of Write	0		0		0		0		ns
t _{HA}	t _{WR}	Address Hold After End of Write	0		0		0		0		ns
t _{HZWE} [13,14]	t _{WZ}	Write Enable to Output Disable		7		8		10		15	ns
t _{LZWE} ^[13]	t _{OW}	Output Active after End of Write	3		3		3		3		ns
t _{BW}	-	Byte Enable to End of Write	15		15		20		30		ns

 Notes

 11. WE must be HIGH during SRAM read cycles.

 12. Device is continuously selected with CE and OE both LOW.

 13. Measured +200 mV from steady state output voltage.

 14. If WE is low when CE goes low, the outputs remain in the high impedance state.



AutoStore/Power Up RECALL

Parameters	Description	CY14B104L	Unit	
	Description	Min	Max	Onit
t _{HRECALL} ^[15]	Power Up RECALL Duration		20	ms
t _{STORE} ^[16]	STORE Cycle Duration		15	ms
V _{SWITCH}	Low Voltage Trigger Level		2.65	V
t _{VCCRISE}	VCC Rise Time	150		μs

Software Controlled STORE/RECALL Cycle

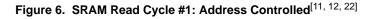
In the following table, the software controlled STORE/RECALL cycle parameters are listed.^[17, 18]

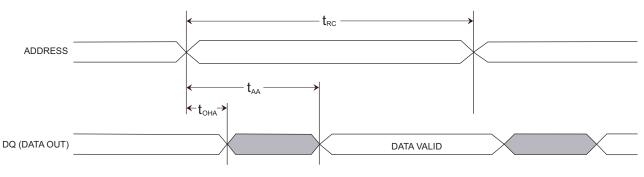
Parameters	Description	15 ns		20 ns		25 ns		45 ns		Unit
Farameters	Description	Min	Max	Min	Max	Min	Max	Min	Max	Onit
t _{RC}	STORE/RECALL Initiation Cycle Time	15		20		25		45		ns
t _{AS}	Address Setup Time	0		0		0		0		ns
t _{CW}	Clock Pulse Width	12		15		20		30		ns
t _{GHAX}	Address Hold Time	1		1		1		1		ns
t _{RECALL}	RECALL Duration		200		200		200		200	μS
t _{SS} ^[19, 20]	Soft Sequence Processing Time		70		70		70		70	μs

Hardware STORE Cycle

Parameters	Description	CY14B104L/	Unit		
	Description	Min	Max	Onit	
t _{DELAY} ^[21]	Time Allowed to Complete SRAM Cycle	1	70	μS	
t _{HLHX}	Hardware STORE Pulse Width	15		ns	

Switching Waveforms

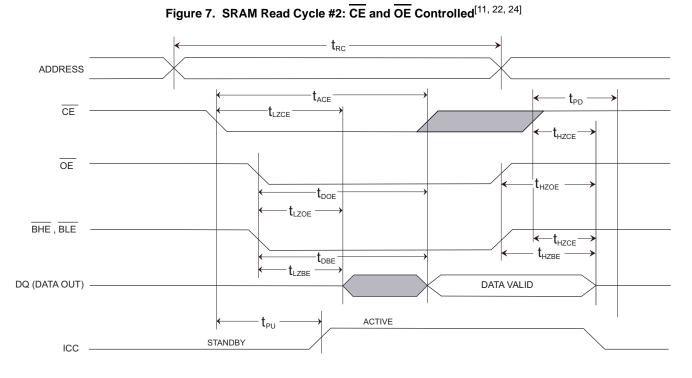




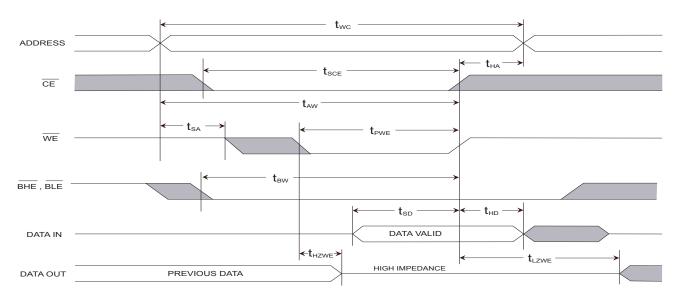
Notes

- t_{HRECALL} starts from the time V_{CC} rises above V_{SWITCH}.
 If an SRAM write has not taken place since the last nonvolatile cycle, no STORE takes place.
- 17. The software sequence is clocked with \overline{CE} controlled or \overline{OE} controlled reads.
- 18. The six consecutive addresses must be read in the order listed in Table 1 on page 5. WE must be HIGH during all six consecutive cycles.
- 19. This is the amount of time it takes to take action on a soft sequence command. Vcc power must remain HIGH to effectively register command.
- 20. Commands such as STORE and RECALL lock out IO until operation is complete which further increases this time. See the specific command
- 21. On a hardware STORE initiation, SRAM operation continues to be enabled for time t_{DELAY} to allow read and write cycles to complete.
- 22. HSB must remain HIGH during READ and WRITE cycles.









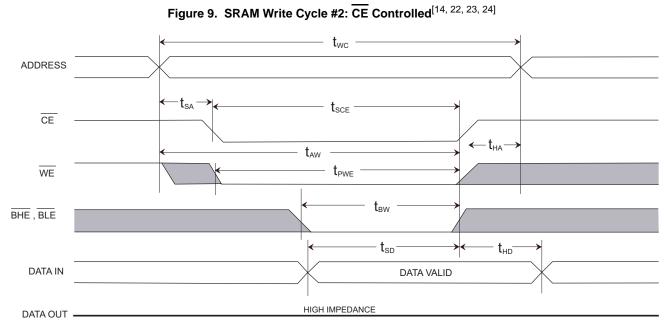
Note<u>s</u>

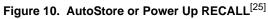
23. <u>CE or WE must be ≥V_{IH} during address transitions.</u> 24. BHE and BLE are applicable for x16 configuration only.

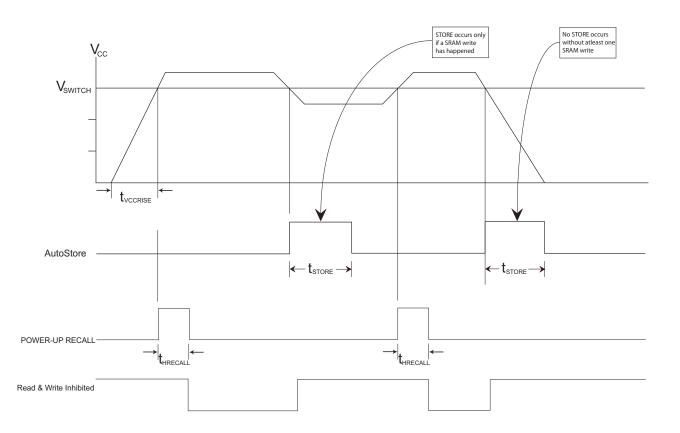
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Note

25. Read and Write cycles are ignored during STORE, RECALL, and while VCC is below V_{SWITCH.}

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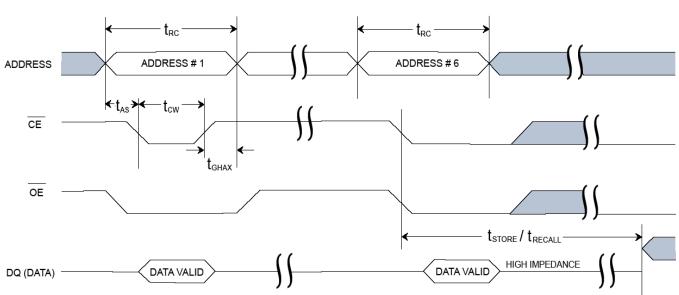
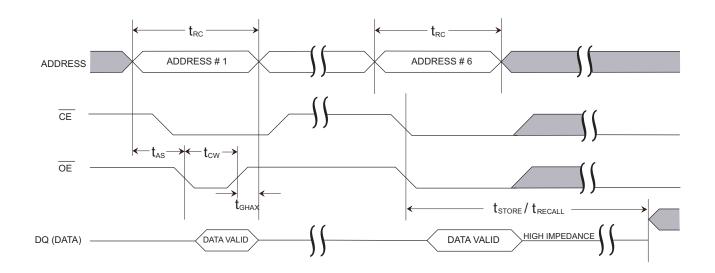
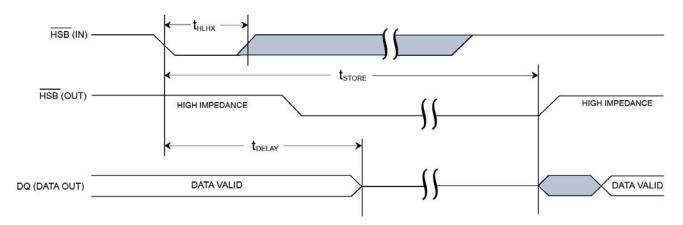


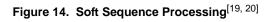
Figure 12. OE Controlled Software STORE/RECALL Cycle^[18]

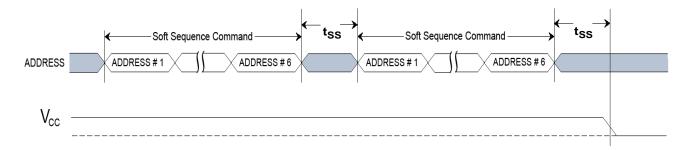














Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
15	CY14B104LA-ZS15XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104L-ZS15XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104L-ZS15XI	51-85087	44-pin TSOP II	
	CY14B104L-BA15XCT	51-85128	48-ball FBGA	Commercial
	CY14B104L-BA15XIT	51-85128	48-ball FBGA	Industrial
	CY14B104L-BA15XI	51-85128	48-ball FBGA	
	CY14B104L-ZSP15XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104L-ZSP15XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104L-ZSP15XI	51-85160	54-pin TSOP II	
	CY14B104N-ZS15XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104N-ZS15XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104N-ZS15XI	51-85087	44-pin TSOP II	
	CY14B104N-BA15XCT	51-85128	48-ball FBGA	Commercial
	CY14B104N-BA15XIT	51-85128	48-ball FBGA	Industrial
	CY14B104N-BA15XI	51-85128	48-ball FBGA	
	CY14B104N-ZSP15XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104N-ZSP15XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104N-ZSP15XI	51-85160	54-pin TSOP II	
20	CY14B104LA-ZS20XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104L-ZS20XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104L-ZS20XI	51-85087	44-pin TSOP II	
	CY14B104L-BA20XCT	51-85128	48-ball FBGA	Commercial
	CY14B104L-BA20XIT	51-85128	48-ball FBGA	Industrial
	CY14B104L-BA20XI	51-85128	48-ball FBGA	
	CY14B104L-ZSP20XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104L-ZSP20XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104L-ZSP20XI	51-85160	54-pin TSOP II	
	CY14B104N-ZS20XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104N-ZS20XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104N-ZS20XI	51-85087	44-pin TSOP II	
	CY14B104N-BA20XCT	51-85128	48-ball FBGA	Commercial
	CY14B104N-BA20XIT	51-85128	48-ball FBGA	Industrial
	CY14B104N-BA20XI	51-85128	48-ball FBGA	
	CY14B104N-ZSP20XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104N-ZSP20XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104N-ZSP20XI	51-85160	54-pin TSOP II	

PRELIMINARY



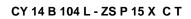
Ordering Information (continued)

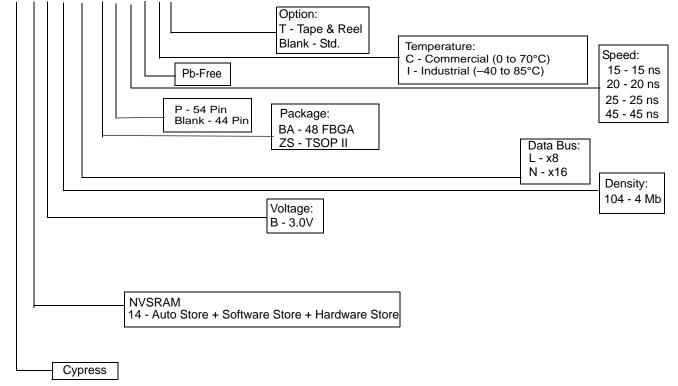
Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
25	CY14B104L-ZS25XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104L-ZS25XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104L-ZS25XI	51-85087	44-pin TSOP II	
	CY14B104L-BA25XIT	51-85128	48-ball FBGA	Industrial
	CY14B104L-BA25XI	51-85128	48-ball FBGA	
	CY14B104N-BA25XCT	51-85128	48-ball FBGA	Commercial
	CY14B104L-ZSP25XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104L-ZSP25XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104L-ZSP25XI	51-85160	54-pin TSOP II	
	CY14B104N-ZS25XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104N-ZS25XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104N-ZS25XI	51-85087	44-pin TSOP II	
	CY14B104N-BA25XCT	51-85128	48-ball FBGA	Commercial
	CY14B104N-BA25XIT	51-85128	48-ball FBGA	Industrial
	CY14B104N-BA25XI	51-85128	48-ball FBGA	
	CY14B104N-ZSP25XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104N-ZSP25XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104N-ZSP25XI	51-85160	54-pin TSOP II	
45	CY14B104L-ZS45XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104L-ZS45XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104L-ZS45XI	51-85087	44-pin TSOP II	
	CY14B104L-BA45XCT	51-85128	48-ball FBGA	Commercial
	CY14B104L-BA45XIT	51-85128	48-ball FBGA	Industrial
	CY14B104L-BA45XI	51-85128	48-ball FBGA	
	CY14B104L-ZSP45XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104L-ZSP45XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104L-ZSP45XI	51-85160	54-pin TSOP II	
	CY14B104N-ZS45XCT	51-85087	44-pin TSOP II	Commercial
	CY14B104N-ZS45XIT	51-85087	44-pin TSOP II	Industrial
	CY14B104N-ZS45XI	51-85087	44-pin TSOP II	
	CY14B104N-BA45XCT	51-85128	48-ball FBGA	Commercial
	CY14B104N-BA45XIT	51-85128	48-ball FBGA	Industrial
	CY14B104N-BA45XI	51-85128	48-ball FBGA	
	CY14B104N-ZSP45XCT	51-85160	54-pin TSOP II	Commercial
	CY14B104N-ZSP45XIT	51-85160	54-pin TSOP II	Industrial
	CY14B104N-ZSP45XI	51-85160	54-pin TSOP II	

All parts are Pb-free. The above table contains Preliminary information. Please contact your local Cypress sales representative for availability of these parts.



Part Numbering Nomenclature



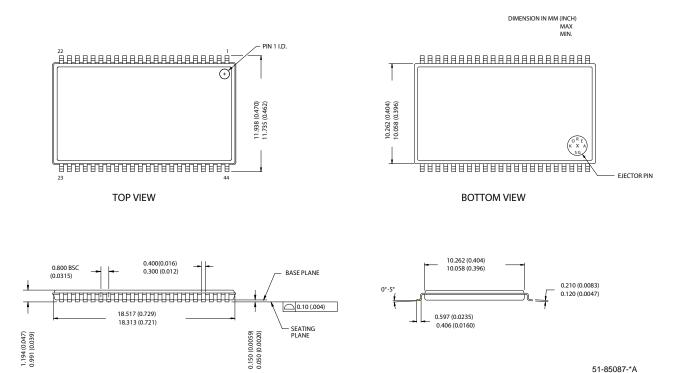






Package Diagrams

Figure 15. 44-Pin TSOP II (51-85087)

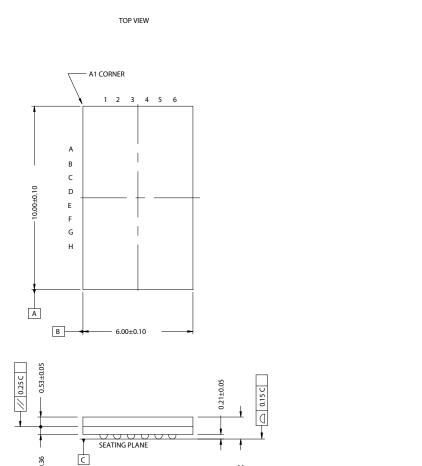


51-85087-*A

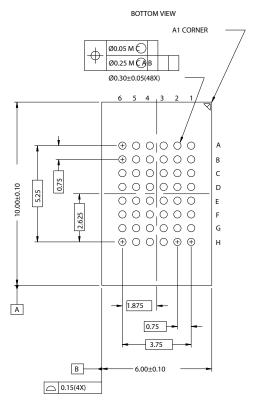


Package Diagrams (continued)





1.20 MAX



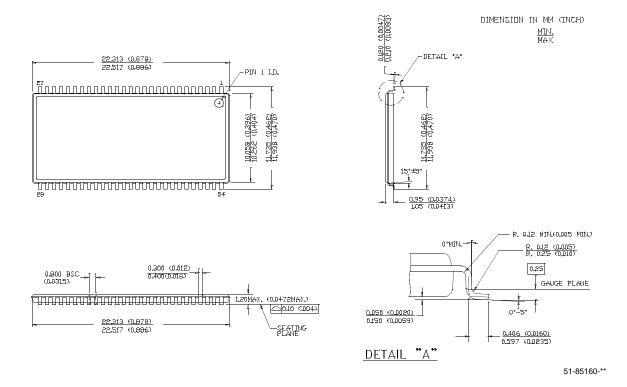
51-85128-*D

0.36



Package Diagrams (continued)

Figure 17. 54-Pin TSOP II (51-85160)





Document History Page

		CY14B104L/CY er: 001-07102	′14B104N 4	Mbit (512K x 8/256K x 16) nvSRAM
Rev.	ECN No.	Submission Date	Orig. of Change	Description of Change
**	431039	See ECN	TUP	New Data Sheet
*A	489096	See ECN	TUP	Removed 48 SSOP Package Added 48 FBGA and 54 TSOPII Packages Updated Part Numbering Nomenclature and Ordering Information Added Soft Sequence Processing Time Waveform
*B	499597	See ECN	PCI	Removed 35 ns speed bin Added 55 ns speed bin. Updated AC table for the same Changed "Unlimited" read/write to "infinite" read/write Features section: Changed typical I _{CC} at 200-ns cycle time to 8 mA Changed STORE cycles from 500K to 200K cycles Shaded Commercial grade in operating range table Modified Icc/Is specs 48 FBGA package nomenclature changed from BW to BV Modified part nomenclature table. Changes reflected in ordering information table
*C	517793	See ECN	TUP	Removed 55ns speed bin Changed pinout for 44TSOPII and 54TSOPII packages Changed I_{SB} to 1mA Changed I_{CC4} to 3mA Changed V_{CAP} min to 35 μ F Changed V_{IH} max to Vcc + 0.5V Changed I_{STORE} to 15ms Changed I_{STORE} to 15ms Changed I_{SCE} to 15ns Changed I_{SCE} to 15ns Changed I_{SD} to 5ns Changed I_{HLBL} Added Timing Parameters for BHE and BLE - I_{DBE} , I_{LZBE} , I_{HZBE} , I_{BW} Removed I_{HLBL} Added Timing Parameters for Vswitch Changed I_{GLAX} to 1ns Added I_{DELAY} max of 70us Changed I_{SS} specification from 70us min to 70us max
*D	774001	See ECN	UHA	Changed the data sheet from Advance information to Preliminary 48 FBGA package code changed from BV to BA Removed 48 FBGA package in X8 configuration in ordering information. Changed t _{DBE} to 10ns in 15ns part Changed t _{HZBE} in 15ns part to 7ns and in 25ns part to10ns Changed t _{BW} in 15ns part to 15ns and in 25ns part to 20ns Changed t _{GLAX} to t _{GHAX} Changed the value of I _{CC3} to 25mA Changed the value of t _{AW} in 15ns part to15ns Changed A ₁₈ and A ₁₉ Pins in FBGA Pin Configuration to NC
*E	914220	See ECN	UHA	Included all the information for 45 ns part in this data sheet



	Document Title: CY14B104L/CY14B104N 4 Mbit (512K x 8/256K x 16) nvSRAM Document Number: 001-07102							
Rev.	ECN No.	Submission Date	Orig. of Change	Description of Change				
*F	1889928	See ECN	vsutmp8/ AESA	Added Footnotes 1, 2 and 3. Updated logic block diagram Added 48-FBGA (X8) Pin Diagram Changed 8Mb Address expansion Pin from Pin 43 to Pin 42 for 44-TSOP II (x8). Updated pin definitions table. Corrected typo in V_{IL} min spec Changed the value of I_{CC3} from 25mA to 13mA Changed I _{SB} value from 1mA to 2mA Rearranging of Footnotes. Updated ordering information table				
*G	2267286	See ECN	GVCH/P YRS	Added $\overline{\text{BHE}}$ and $\overline{\text{BLE}}$ Information in Pin Definitions Table Updated Figure 4 (Autostore mode) Updated footnote 6 Changed I _{CC2} & I _{CC4} from 3 mA to 6 mA Changed I _{CC3} from 13 mA to 15 mA Changed Vcap from 35uF min and 57uF max value to 54uF min and 82uF max value Changed I _{SB} from 2 mA to 3 mA Added input leakage current (I _{IX}) for HSB in DC Electrical Characteristics table Corrected typo in t _{DBE} value from 22 ns to 20 ns for 45 ns part Corrected typo in t _{HZBE} value from 22 ns to 15 ns for 45 ns part Corrected typo in t _{AW} value from 15 ns to 10ns for 15 ns part Changed t _{RECALL} from 100 to 200 us Added footnotes 9 and 25; Reframed footnote 14 and 21 Added footnote 14 to figure 7 (SRAM WRITE Cycle #1)				
*H	2483627	See ECN	GVCH/P YRS	Removed 8 mA typical I _{CC} at 200 ns cycle time in Feature section Referenced footnote 8 to I _{CC3} in DC Characteristics table Changed I _{CC3} from 15 mA to 35 mA Changed Vcap minimum value from 54 uF to 61 uF Changed t _{AVAV} to t _{RC} Figure 11:Changed t _{SA} to t _{AS} and t _{SCE to} t _{CW}				



Document Title: CY14B104L/CY14B104N 4 Mbit (512K x 8/256K x 16) nvSRAM Document Number: 001-07102							
Rev.	ECN No.	Submission Date	Orig. of Change	Description of Change			
*	2519319	06/20/08	GVCH/P YRS	Added 20 ns access speed in "Features" Added I_{CC1} for t_{RC} =20 ns for both industrial and Commecial temperature Grade updated Thermal resistance table values for 48-FBGA, 44-TSOP II and 54-TSOP II Packages Added AC Switching Characteristics specs for 20 ns access speed Added software controlled STORE/RECALL cycle specs for 20 ns access speed Updated ordering information and part numbering nomenclature			

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Document #: 001-07102 Rev. *I

Revised June 20, 2008

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